Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	der	
10/710,934	CHEN ET AL.		
Examiner	Art Unit		
David Mis	2817		

SEARCHED					
Class	Subclass	Date	Examiner		
331	1A, 10, 11,	12/7/2005	DM		
	16, 18,				
	25				
327	156-159				
332	127				
360	51				
375	376				
- 455	260				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
1296911	(see Kistory)	3/14/6	æ		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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